

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/532,685	SAITO, TAKASHI	
Examiner		Art Unit		Page 1 of 1
Tri V. Nguyen		1751		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0206942	10-2004	Hsu, Che-Hsiung	252/500
*	B	US-2003/0122111	07-2003	Glatkowski, Paul J.	252/500
*	C	US-2002/0161101	10-2002	Carroll et al.	524/495
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 03/013199A2	02-2003	US	Eikos, Inc.	D01F 9/12
	O	JP 2000-219739	08-2000	Japan	Mitsubishi Rayon Co LTD	C08G 73/00
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	STN search report. pg 1-4.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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